



RADIO TEST REPORT

Test Report No.: 32FE0253-HO-F

Applicant : SAMSUNG ELECTRONICS CO., LTD.
Type of Equipment : GPRS850/1900, EDGE850/1900, WCDMA2,
WCDMA5 Tablet with 802.11bgn, BT3.0+EDR
Model No. : GT-P5100
Test standard : FCC Part 24 Subpart E: 2008
FCC ID : A3LGTP5100
Test Result : **Complied**

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test: February 6 to 13, 2012

Representative test engineer:

Katsunori Okai
Engineer of WiSE Japan,
UL Verification Service

Approved by:

Takahiro Hatakeda
Leader of WiSE Japan,
UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

13-EM-F0429

CONTENTS	PAGE
SECTION 1: Customer information	3
SECTION 2: Equipment under test (E.U.T.)	3
SECTION 3: Test specification, procedures & results	5
SECTION 4: Operation of E.U.T. during testing.....	8
SECTION 5: RF Output Power(Conducted/Radiated).....	14
SECTION 6: Bandwidth (Conducted)	15
SECTION 7: Spurious Emission and Band-Edge (Conducted/Radiated)	15
SECTION 8: Frequency Stability(Temperature/Voltage Variation).....	16
APPENDIX 1: Data of EMI test	17
RF Output Power (Conducted)	17
RF Output Power (Radiated)	19
Peak to Average power Ratio (Conducted)	21
Bandwidth(Conducted)	23
Band-Edge(Conducted).....	26
Band-Edge (Radiated).....	29
Spurious Emission (Conducted)	30
Spurious Emission (Radiated)	42
Frequency Stability (Temperature/Voltage Variation).....	44
APPENDIX 2: Test instruments	46
APPENDIX 3: Photographs of test setup.....	48
Radiated Spurious Emission.....	48
Worst Case Position (Horizontal: Y-axis/ Vertical:Z-axis)	49

SECTION 1: Customer information

Company Name : SAMSUNG ELECTRONICS CO., LTD.
Address : 416, MAETAN 3-DONG, YEONGTONG-GU SUWON-CITY,
GYEONGGI-DO 443-742, SOUTH KOREA

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : GPRS850/1900, EDGE850/1900, WCDMA2, WCDMA5 Tablet with
802.11bgn, BT3.0+EDR
Model No. : GT-P5100
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC5.0V
Receipt Date of Sample : February 6, 2012
Modification of EUT : No Modification by the test lab

2.2 Product Description

Radio Specification

Bluetooth

Equipment Type	Transceiver
Frequency of Operation	2402-2480MHz
Type of Modulation	FHSS
Bandwidth & Channel spacing	1MHz & 1MHz
Antenna Type	PIFA
Antenna Gain	-0.31 dBi (MAX)

WLAN (IEEE802.11b/g/n-20)

Equipment Type	Transceiver
Frequency of Operation	2412-2462MHz
Type of Modulation	DSSS, OFDM
Bandwidth & Channel spacing	20MHz & 5MHz
Antenna Type	PIFA
Antenna Gain	-0.31 dBi (MAX)

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

GSM

Equipment Type	Transceiver
Frequency of Operation	[Up Link] GSM850: 824 – 849MHz PCS: 1850 – 1910MHz [Down Link] GSM850: 869 – 894MHz PCS: 1930 – 1990MHz
Type of Modulation	GMSK , 8PSK
Emission Designator	GSM850: 249KGXW, 256KG7W PCS: 249KGXW, 262KG7W
Antenna Type	PIFA
Antenna Gain	GSM850: 824-849MHz: -4.63dBi (MAX) 869-894MHz: -2.35dBi (MAX) PCS: 1850-1910MHz: -5.1dBi (MAX) 1930-1990MHz: -5.55dBi (MAX)

W-CDMA

Equipment Type	Transceiver
Frequency of Operation	[Up Link] Band V: 824 – 849MHz Band II: 1850 – 1910MHz [Down Link] Band V: 869 – 894MHz Band II: 1930 – 1990MHz
Type of Modulation	QPSK
Emission Designator	Band V: 4M06F9W Band II: 4M06F9W
Antenna Type	PIFA
Antenna Gain	Band V: 824-849MHz: -4.63dBi (MAX) 869-894MHz: -2.35dBi (MAX) Band II: 1850-1910MHz: -5.1dBi (MAX) 1930-1900MHz: -5.55dBi (MAX)

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 24 Subpart E: 2008, final revised on May 2, 2008
Title : FCC 47CFR Part 24 Subpart E
Broadband PCS

3.2 Procedures and results

Item	Test Specification & Procedure	Remarks	Deviation	Worst margin	Results
RF Output Power(Conducted/ Radiated) (Conducted Output Power / Equivalent isotropic radiated power(EIRP))	FCC 2.1046 FCC 24.232(c)	Conducted/ Radiated	N/A	-	Complied
Peak to Average power Ratio	FCC 24.232(d)	Conducted	N/A	-	Complied
Emission Bandwidth, 99% Occupied Bandwidth	FCC 2.1049 FCC 24.238	Conducted	N/A	-	Complied
Band-Edge	FCC 2.1051 FCC 2.1053 FCC 24.238	Conducted/ Radiated	N/A	GSM [Conducted] 7.23dB 1849.9899MHz [Radiated] 7.8dB 1910.02MHz, Horizontal W-CDMA [Conducted] 6.52dB 1910.0000MHz [Radiated] 4.6dB 1850.00MHz, Horizontal	Complied
Spurious Emission(Conducted)	FCC 2.1051 FCC 24.238	Conducted	N/A	-	Complied
Spurious Emission(Radiated)	FCC 2.1053 FCC 24.238	Radiated	N/A	GSM 37.7dB 5640.00MHz, Horizontal W-CDMA No signal detected	Complied
Frequency Stability (Temperature Variation)	FCC 2.1055(a)(1)(b) FCC 24.235	Conducted	N/A	-	Complied
Frequency Stability (Voltage Variation)	FCC 2.1055(d)(1)(2) FCC 24.235	Conducted	N/A	-	Complied
Note: UL Japan's EMI Work Procedures No. 13-EM-W0420					

*These tests were also referred to ANSI/TIA 603-C-2004 " Land Mobile FM or PM Communications Equipment Measurement and Performance Standards."

*These tests were performed without any deviations from test procedure except for additions or exclusions.

3.3 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Radiated Emission (EUT height: 0.8m) (±dB)	
Measurement Distance 3m	
30MHz-300MHz	5.4dB
300MHz-1000MHz	4.0dB
1GHz-12.75GHz	4.4dB

Power meter (±dB)	
Below 1GHz	Above 1GHz
1.0dB	1.0dB

Antenna terminal conducted emission and Power density (±dB)			Antenna terminal conducted emission (±dB)		Channel power (±dB)
Below 1GHz	1GHz-3GHz	3GHz-18GHz	18GHz-26.5GHz	26.5GHz-40GHz	
1.0dB	1.1dB	2.7dB	3.2dB	3.3dB	1.5dB

Antenna Terminal Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

3.4 Test Location

UL Japan, Inc. Head Office EMC Lab. *NVLAP Lab. code: 200572-0
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.5 Test set up, Test instruments and Data of EMI

Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

<PCS1900>

Test	Operating mode	Power Control	Tested frequency	Channel
RF output Power(Conducted) Peak to Average power Ratio (Conducted)	Transmitting (Tx) (GSM, GMSK, 1slot) Transmitting (Tx) (GPRS, GMSK, 1slot, CS-1) Transmitting (Tx) (EGPRS, 8PSK, 2slot, MCS-5)	Max (PCL=0)	1850.2MHz 1880.0MHz 1909.8MHz	512 661 810
RF output Power(Radiated)	Transmitting (Tx) (GSM, GMSK, 1slot) Transmitting (Tx) (EGPRS, 8PSK, 2slot, MCS-5)	Max (PCL=0)	1850.2MHz 1880.0MHz 1909.8MHz	512 661 810
Emission Bandwidth, 99% Occupied bandwidth,	Transmitting (Tx) (GSM, GMSK, 1slot) Transmitting (Tx) (EGPRS, 8PSK, 2slot, MCS-5)	Max (PCL=0)	1880.0MHz	661
Band Edge(Conducted)	Transmitting (Tx) (GSM, GMSK, 1slot) Transmitting (Tx) (EGPRS, 8PSK, 2slot, MCS-5)	Max (PCL=0)	1850.2MHz 1909.8MHz	512 810
Band Edge(Radiated)	Transmitting (Tx) (GSM, GMSK, 1slot)	Max (PCL=0)	1850.2MHz 1909.8MHz	512 810
Spurious Emission(Conducted)	Transmitting (Tx) (GSM, GMSK, 1slot) Transmitting (Tx) (EGPRS, 8PSK, 2slot, MCS-5)	Max (PCL=0)	1850.2MHz 1880.0MHz 1909.8MHz	512 661 810
Spurious Emission(Radiated)	Transmitting (Tx) (GSM, GMSK, 1slot)	Max (PCL=0)	1850.2MHz 1880.0MHz 1909.8MHz	512 661 810
Frequency Stability (Temperature/Voltage Variation)	Transmitting (Tx) (GSM, GMSK)	Max	1880.0MHz	661

[GSM, GPRS]

*Single slot (1 slot) which had the highest frame power was tested as a representative.

[EGPRS]

*Multi slot (2 slot) which had the highest frame power was tested as a representative.

<W-CDMA Band II>

Test	Operating mode	Power Control	Tested frequency	Channel
RF output Power(Conducted)	Transmitting (Tx) W-CDMA (RMC12.2kbps) Transmitting (Tx) W-CDMA (AMR) Transmitting (Tx) W-CDMA (HSDPA Subtest 1-4) Transmitting (Tx) W-CDMA (HSUPA Subtest 1-5)	See Section 4.1.1	1852.4 MHz 1880.0 MHz 1907.6 MHz	9262 9400 9538
RF output Power (Radiated), Spurious Emission (Conducted/Radiated), Peak to Average power Ratio (Conducted)	Transmitting (Tx) W-CDMA (RMC12.2kbps)	TPC All Up bits(Max)	1852.4 MHz 1880.0 MHz 1907.6 MHz	9262 9400 9538
Peak to Average power Ratio (Conducted)	Transmitting (Tx) W-CDMA (RMC12.2kbps)	TPC All Up bits(Max)	1852.4 MHz 1880.0 MHz 1907.6 MHz	9262 9400 9538
Band Edge (Conducted/Radiated)	Transmitting (Tx) W-CDMA (RMC12.2kbps)	TPC All Up bits(Max)	1852.4 MHz 1907.6 MHz	9262 9538
Emission Bandwidth, 99% Occupied bandwidth, Frequency Stability (Temperature/Voltage Variation)	Transmitting (Tx) W-CDMA (RMC12.2kbps)	TPC all up bits (MAX)	1880.0 MHz	9400

*The WCDMA and HSPA modes of EUT were verified on each channel and "sub-tests" according to section 4.1.1. (Also refer to Release-6 procedures in section 5.2 of 3GPP TS 34.121.)

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

4.1.1 Explanation of the Rel-99 WCDMA and Rel-6 HSPA measurement mode

3GPP defines UE Test Modes and Channel Configurations for Regulatory Testing.

- **UE Test Modes:**
Test Mode 1(Data Loopback Test)
- **Channel Configurations:**
R99 – 12.2kpbs Reference Measurement Channel (RMC) channel
HSDPA – Fixed Reference Channel (FRC)
HSUPA – New HSUPA channel configuration (HSDPA data from DL is looped back onto UL)
- **Procedure to configure UE to transmit maximum power:**
Rel99: 3GPP TS 34.121 section 5.2
HSDPA Rel5: 3GPP TS 34.121 section 5.2A
HSDPA Rel6: 3GPP TS 34.121 section 5.2AA
HSUPA Rel6: 3GPP TS 34.121 section 5.2B

* About Rel-99 and HSDPA testing, test equipment send “all up bits” forcing UE max power

(1) Explanation for HSDPA/HSPA Subtests

3GPP TS 34.121 defines test requirements and procedures for testing all variations of WCDMA. 3GPP TS 34.121 defines 4 HSDPA test configurations and 5 HSPA test configurations (“Subtests”) for various RF Conformance tests. The Following table shows Release 5 HSDPA and Release 6 HSPA Subtest Configurations per 3GPP TS 34.121.

[HSDPA]

Table C.10.1.4: β values for transmitter characteristics tests with HS-DPCCH

Sub-test	β_c	β_d	β_d (SF)	β_c/β_d	β_{HS} (Note 1, Note 2)	CM (dB) (Note 3)	MPR (dB) (Note 3)
1	2/15	15/15	64	2/15	4/15	0.0	0.0
2	12/15	15/15	64	12/15	24/15	1.0	0.0
	(Note 4)	(Note 4)		(Note 4)			
3	15/15	8/15	64	15/8	30/15	1.5	0.5
4	15/15	4/15	64	15/4	30/15	1.5	0.5

Note 1: Δ_{ACK} , Δ_{NACK} and $\Delta_{CQI} = 30/15$ with $\beta_{HS} = 30/15 * \beta_c$.

Note 2: For the HS-DPCCH power mask requirement test in clause 5.2C, 5.7A, and the Error Vector Magnitude (EVM) with HS-DPCCH test in clause 5.13.1A, and HSDPA EVM with phase discontinuity in clause 5.13.1AA, Δ_{ACK} and $\Delta_{NACK} = 30/15$ with $\beta_{HS} = 30/15 * \beta_c$, and $\Delta_{CQI} = 24/15$ with $\beta_{HS} = 24/15 * \beta_c$.

Note 3: CM = 1 for $\beta_c/\beta_d = 12/15$, $\beta_{HS}/\beta_c = 24/15$. For all other combinations of DPDCCH, DPCCH and HS-DPCCH the MPR is based on the relative CM difference. This is applicable for only UEs that support HSDPA in release 6 and later releases.

Note 4: For subtest 2 the β_c/β_d ratio of 12/15 for the TFC during the measurement period (TF1, TF0) is achieved by setting the signalled gain factors for the reference TFC (TF1, TF1) to $\beta_c = 11/15$ and $\beta_d = 15/15$.

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

[HSUPA]

Table C.11.1.3: β values for transmitter characteristics tests with HS-DPCCH and E-DCH

Sub-test	β_c	β_d	β_d (SF)	β_c/β_d	β_{HS} (Note 1)	β_{oc}	β_{ed} (Note 5) (Note 6)	β_{ed} (SF)	β_{ed} (Codes)	CM (dB) (Note 2)	MPR (dB) (Note 2)	AG Index (Note 6)	E-TFCI
1	11/15 (Note 3)	15/15 (Note 3)	64	11/15 (Note 3)	22/15	209/25	1309/225	4	1	1.0	0.0	20	75
2	6/15	15/15	64	6/15	12/15	12/15	94/75	4	1	3.0	2.0	12	67
3	15/15	9/15	64	15/9	30/15	30/15	β_{ed1} : 47/15 β_{ed2} : 47/15	4	2	2.0	1.0	15	92
4	2/15	15/15	64	2/15	4/15	2/15	56/75	4	1	3.0	2.0	17	71
5	15/15 (Note 4)	15/15 (Note 4)	64	15/15 (Note 4)	30/15	24/15	134/15	4	1	1.0	0.0	21	81

Note 1: Δ_{ACK} , Δ_{NACK} and $\Delta_{CQI} = 30/15$ with $\beta_{ex} = 30/15 * \beta_c$.

Note 2: CM = 1 for $\beta_c/\beta_d = 12/15$, $\beta_{ex}/\beta_c = 24/15$. For all other combinations of DPDCH, DPCCH, HS-DPCCH, E-DPDCH and E-DPCCH the MPR is based on the relative CM difference.

Note 3: For subtest 1 the β_c/β_d ratio of 11/15 for the TFC during the measurement period (TF1, TF0) is achieved by setting the signalled gain factors for the reference TFC (TF1, TF1) to $\beta_c = 10/15$ and $\beta_d = 15/15$.

Note 4: For subtest 5 the β_c/β_d ratio of 15/15 for the TFC during the measurement period (TF1, TF0) is achieved by setting the signalled gain factors for the reference TFC (TF1, TF1) to $\beta_c = 14/15$ and $\beta_d = 15/15$.

Note 5: In case of testing by UE using E-DPDCH Physical Layer category 1, Sub-test 3 is omitted according to TS25.306 Table 5.1g.

Note 6: β_d can not be set directly, it is set by Absolute Grant Value.

(2) Maximum Output Power Verification

[HSDPA]

Maximum output power was verified on High, Middle and Low channels according to the Release 5 procedures described in section 5.2 of 3GPP TS 34.121, using an FRC with H-set 1 and 12.2kbps RMC with TPC (transmit power control) set to all "1's". Output power was measured according requirements for HS-DPCCH Sub-test 1-4.

[HSUPA]

Maximum output power was verified on the High, Middle and Low channels according to Release 6 procedures in section 5.2 of 3GPP TS 34.121, using the appropriate RMC, FRC and E-DCH configurations. When E-DCH was active, inner loop power control with power control algorithm 2 was used to maintain E-TFCI requirements. Output power for the applicable HSPA modes was measured for E-DCH Sub-test 1-5.

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

(3) Test Equipment Setting Summary Table

The following table is the key parameters that was configured in test equipment.

Subtest	Mode	Loopback Mode	Rel99 RMC	HSDPA FRC	HSUPA Test	Common Setting		β_c/β_d	MPR	Power Class 3 limit
						β_c	β_d			
	Rel99	Test Mode 1	12.2kbps RMC	-	-	-	-	8/15	-	24(+1.7/-3.7dB)
1	Rel6 HSDPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	-	2/15	15/15	2/15	0	24(+1.7/-3.7dB)
2	Rel6 HSDPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	-	12/15	15/15	12/15	0	24(+1.7/-3.7dB)
3	Rel6 HSDPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	-	15/15	8/15	15/8	0.5	23.5(+2.2/-3.7dB)
4	Rel6 HSDPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	-	15/15	4/15	15/4	0.5	23.5(+2.2/-3.7dB)
1	Rel6 HSUPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	HSUPA Loopback	11/15	15/15	11/15	0	24(+1.7/-3.7dB)
2	Rel6 HSUPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	HSUPA Loopback	6/15	15/15	6/15	2	22(+3.7/-3.7dB)
3	Rel6 HSUPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	HSUPA Loopback	15/15	9/15	15/9	1	23(+2.7/-3.7dB)
4	Rel6 HSUPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	HSUPA Loopback	2/15	15/15	2/15	2	22(+3.7/-3.7dB)
5	Rel6 HSUPA	Test Mode 1	12.2kbps RMC	H-Set 1 (QPSK)	HSUPA Loopback	15/15	15/15	15/15	0	24(+1.7/-3.7dB)

Subtest	HSDPA Specific Settings						
	Δ ACK	Δ NACK	Δ CQI	Ack-Nack repetition factor	CQI Feedback	CQI Repetition Factor	Ahs= β_{hs}/β_c
Rel 6 HSDPA							
1	8	8	8	3	4ms	2	30/15
2	8	8	8	3	4ms	2	30/15
3	8	8	8	3	4ms	2	30/15
4	8	8	8	3	4ms	2	30/15

Subtest	HSDPA Specific Settings							HSUPA Specific Settings			HSUPA Additional Info	
	Δ ACK	Δ NACK	Δ CQI	Ack-Nack repetition factor	CQI Feedback	CQI Repetition Factor	Ahs= β_{hs}/β_c	Δ E-DPCCH	Δ HARQ	AG Index	ETFCI (form TS34.121 Table C.11.1.3)	Associated Max UL Data Rate kbps
Rel 6 HSPA												
1	8	8	8	3	4ms	2	30/15	6	0	20	75	242.1
2	8	8	8	3	4ms	2	30/15	8	0	12	67	174.9
3	8	8	8	3	4ms	2	30/15	8	0	15	92	482.8
4	8	8	8	3	4ms	2	30/15	5	0	17	71	205.8
5	8	8	8	3	4ms	2	30/15	7	0	21	81	308.9

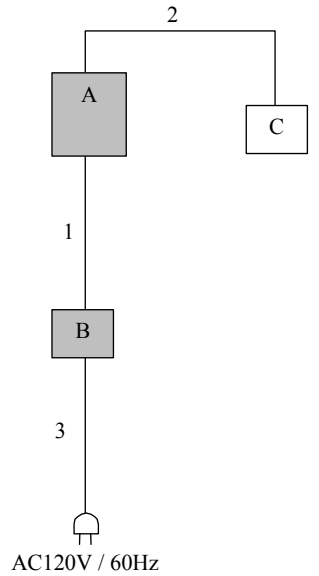
HSUPA Reference E-TFCI Parameters
[Subtest 1, 2, 4, 5]

Information Element	Value/Remark
E-DCH info	Uplink DPCH info
- E-DPDCH info	
- Reference E-TFCIs	5 E-TFCIs
- Reference E-TFCI	11
- Reference E-TFCI PO	4
- Reference E-TFCI	67
- Reference E-TFCI PO	18
- Reference E-TFCI	71
- Reference E-TFCI PO	23
- Reference E-TFCI	75
- Reference E-TFCI PO	26
- Reference E-TFCI	81
- Reference E-TFCI PO	27

[Subtest 3]

Information Element	Value/Remark
E-DCH info	Uplink DPCH info
- E-DPDCH info	
- Reference E-TFCIs	2 E-TFCIs
- Reference E-TFCI	11
- Reference E-TFCI PO	4
- Reference E-TFCI	92
- Reference E-TFCI PO	18

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	GPRS850/1900, EDGE850/1900, WCDMA2, WCDMA5 Tablet with 802.11bgn, BT3.0+EDR	GT-P5100	R31C10LKEXF *1) R31C10LKEYR *2) R31C10LKEZH *3)	SAMSUNG	EUT
B	AC Adapter	ETA-P11X	-	SAMSUNG	EUT
C	Ear phone	-	-	SAMSUNG	-

*1) Used for Antenna Terminal Conducted test

*2) Used for Radiated Emission test

*3) Used for RF Output Power (Conducted) test

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	USB Cable	1.0	Shielded	Shielded	-
2	Ear phone Cable	1.2	Unshielded	Unshielded	-
3	AC Cable	0.9	Unshielded	Unshielded	-

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

SECTION 5: RF Output Power(Conducted/Radiated)

[Conducted: Conducted Output Power]

Test Procedure

The RF output power (conducted) was measured with Wireless Communication Test Set and an attenuator at the antenna port.

Test data : **APPENDIX 2**
Test result : **Pass**

[Radiated : Equivalent isotropic radiated power(EIRP)]

Test Procedure

- 1) EUT was placed on a platform of nominal size, 0.5 by 1.0m, raised 80cm above the conducting ground plane. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The Radiated Electric Field Strength intensity has been measured in a semi anechoic chamber with a ground plane and at a distance of 3m.
The measuring antenna height varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.
- 2) Exchanged the EUT to the Substitution Antenna, the measurement was set for the same height as the EUT. The frequency above 1GHz of the Substitution antenna was used with Horn antenna calibrated with the Half wave dipole antenna, which is harmonized with the measured frequency in 1).
The Substitution Antenna was connected with the Signal Generator, and the polarized electromagnetic radiation of the Substitution Antenna was matched with the one of the measuring Antenna, which was set with the Signal Generator to the measured frequency in 1). Then, we set with the Output power (CW) of the Signal Generator where the measuring electromagnetic field is equal to the measured value in 1).
The measuring antenna height varied between 1 and 4m to obtain the maximum receiving level.
Its Output power of Signal Generator was recorded.
- 3) Equivalent isotropic radiated power(EIRP) was calculated by subtracting the cable loss and the attenuator loss connected between the Signal Generator and the Substitution Antenna from the Output power of the Signal Generator recorded in 2).

- The carrier level and noise levels were confirmed at each position of X, Y and Z axis of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test data : **APPENDIX 1**
Test result : **Pass**

SECTION 6: Bandwidth (Conducted)

Test Procedure

The Emission Bandwidth and 99% Occupied Bandwidth was measured with a spectrum analyzer and attenuator connected to the antenna port.

Test data : **APPENDIX 1**
Test result : **Pass**

SECTION 7: Spurious Emission and Band-Edge (Conducted/Radiated)

[Conducted]

Test Procedure

The Spurious Emission and Band-Edge was measured with a spectrum analyzer and attenuator connected to the antenna port.

[Radiated]

Test Procedure

- 1) EUT was placed on a platform of nominal size, 0.5m by 1.0m, raised 80cm above the conducting ground plane. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The Radiated Electric Field Strength intensity has been measured in a semi anechoic chamber with a ground plane and at a distance of 3m.
The measuring antenna height was varied between 1 to 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.
- 2) Exchanged the EUT to the Substitution Antenna, the antenna was set for the same height as EUT on the table.
The frequency below 1GHz of the Substitution antenna was used as the Half wave dipole antenna and Shorted dipole antenna calibrated with the Half wave dipole antenna, which is harmonized with the measured frequency in 1). The frequency above 1GHz of the Substitution antenna was used with Horn antenna calibrated with the Half wave dipole antenna.
The Substitution antenna was connected with the Signal Generator, and the polarized electromagnetic radiation of the Substitution antenna was matched with the one of the measuring antenna, which was set with the Signal Generator to the measured frequency in 1). Then, we set with the Output power (CW) of the Signal Generator where the measuring electromagnetic field is equal to the measured value in 1).
The measuring antenna height varied between 1 and 4m to obtain the maximum receiving level.
Its Output power of Signal Generator was recorded.
- 3) Equivalent isotropic radiated power was calculated by subtracting the cable loss and the attenuator loss connected between the Signal Generator and the Substitution Antenna from the Output power of the Signal Generator recorded in 2).

- The carrier level and noise levels were confirmed at each position of X, Y and Z axis of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test data : **APPENDIX 1**
Test result : **Pass**

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

SECTION 8: Frequency Stability(Temperature/Voltage Variation)

Test Procedure

The Frequency Stability was measured with a Wireless Communication Test Set and attenuator connected to the antenna port.

The Frequency Drift was measured with the 10 deg. C. steps from -30 deg. C. to 50 deg. C., and it is presented as the ppm unit. The Frequency Drift was measured with the normal temperature (20 deg. C.) and Voltage tolerance (AC 102V to AC 138V), and it is presented as the ppm unit.

Temperature : -30deg.C to +50deg.C (10 deg. C. step)
Voltage : Normal Voltage AC 120V
Maximum Voltage AC 138V(AC 120V +15%)
Minimum Voltage AC 102V (AC 120V -15%)

As the operating input voltage of the EUT is between AC 102V to AC 138V (nominal voltage: AC 120V), Frequency Stability test was performed under the above condition.

Test data : **APPENDIX 1**
Test result : **Pass**

APPENDIX 1: Data of EMI test

RF Output Power (Conducted)

Conducted Output Power PCS1900

Test place Head Office EMC Lab. No.11 Measurement Room
Report No. 32FE0253-HO
Date 02/07/2012
Temperature/ Humidity 21deg.C / 31% RH
Engineer Katsunori Okai
Mode Tx GSM(GMSK), 1slot, PCL=0
Tx GPRS(GMSK), 1slot, CS-1, PCL=0
Tx EGPRS(8PSK), 2slot, MCS-5, PCL=0

Mode	Ch	Frequency [MHz]	Reading	Cable Loss [dB]	Result [dBm]
			Average frame power [dBm]		
GSM	512	1850.2	22.00	6.67	28.67
	661	1880.0	22.23	6.66	28.89
	810	1909.8	21.94	6.67	28.61
GPRS	512	1850.2	22.00	6.67	28.67
	661	1880.0	22.22	6.66	28.88
	810	1909.8	21.92	6.67	28.59
EGPRS	512	1850.2	19.50	6.67	26.17
	661	1880.0	19.71	6.66	26.37
	810	1909.8	19.43	6.67	26.10

Results = Reading + Cable Loss

RF Output Power (Radiated)
Equivalent Isotropically Radiated Power(EIRP)
PCS1900

Report No. 32FE0253-HO-O
Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date 02/06/2012
Temperature / Humidity 25deg. C / 31% RH
Engineer Satofumi Matsuyama
Mode Tx GSM(GMSK), 1slot, PCL=0

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]	Rx Ant. Height [cm]	Turn Table [deg.]	
	1850.20	99.1	99.2	23.0				21.1	4.0		9.8	0.0	28.8	26.9	33.0	4.2	
1880.00	98.7	99.1	22.8	21.5	4.0	9.8	0.0	28.6	27.3	33.0	4.4	5.7	117	353	100	264	
1909.80	97.9	98.4	22.3	21.3	4.0	9.8	0.0	28.1	27.1	33.0	4.9	5.9	120	350	100	270	

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK(RBW:3MHz/VBW:8MHz)

Report No. 32FE0253-HO-O
Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date 02/06/2012
Temperature / Humidity 25deg. C / 31% RH
Engineer Satofumi Matsuyama
Mode Tx EGPRS(8PSK), 2slot, MCS-5, PCL=0

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]	Rx Ant. Height [cm]	Turn Table [deg.]	
	1850.20	98.2	99.1	22.1				21.0	4.0		9.8	0.0	27.9	26.8	33.0	5.1	
1880.00	98.7	98.6	22.8	21.0	4.0	9.8	0.0	28.6	26.8	33.0	4.4	6.2	127	356	102	241	
1909.80	97.5	98.5	21.9	21.4	4.0	9.8	0.0	27.7	27.2	33.0	5.3	5.8	124	357	103	264	

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK (RBW: 3MHz , VBW: 8MHz)

RF Output Power (Radiated)
Equivalent Isotropically Radiated Power(EIRP)
W-CDMA Band II

Report No. 32FE0253-HO-O
Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date 02/06/2012
Temperature / Humidity 25deg. C / 31% RH
Engineer Satofumi Matsuyama
Mode Tx W-CDMA (RMC12.2kbps), All Up Bits

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks		
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]		Rx Ant. Height [cm]	Turn Table [deg.]
1852.40	93.6	94.3	17.0	15.7	4.0	9.8	0.0	22.8	21.5	33.0	10.2	11.5	100	322	102	257			
1880.00	94.3	94.7	17.8	16.6	4.0	9.8	0.0	23.6	22.4	33.0	9.4	10.6	122	319	101	260			
1907.60	94.3	94.2	17.9	16.5	4.0	9.8	0.0	23.7	22.3	33.0	9.3	10.7	124	320	100	262			

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss

Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-20GHz)

Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-20GHz)

Detector : S/A PK (RBW: 5MHz, VBW: 50MHz)

Peak to Average power Ratio (Conducted)

Test place Head Office EMC Lab. No.11 Measurement Room
Report No. 32FE0253-HO
Date 02/09/2012 02/10/2012
Temperature/ Humidity 20deg. C / 24% RH 23deg. C / 23% RH
Engineer Yutaka Yoshida Yutaka Yoshida
Mode Tx GSM(GMSK), 1slot, PCL=0
Tx GPRS(GMSK), 1slot, CS-1, PCL=0
Tx EGPRS(8PSK), 2slot, MCS-5, PCL=0
Tx W-CDMA(RMC12.2kbps), All Up Bits

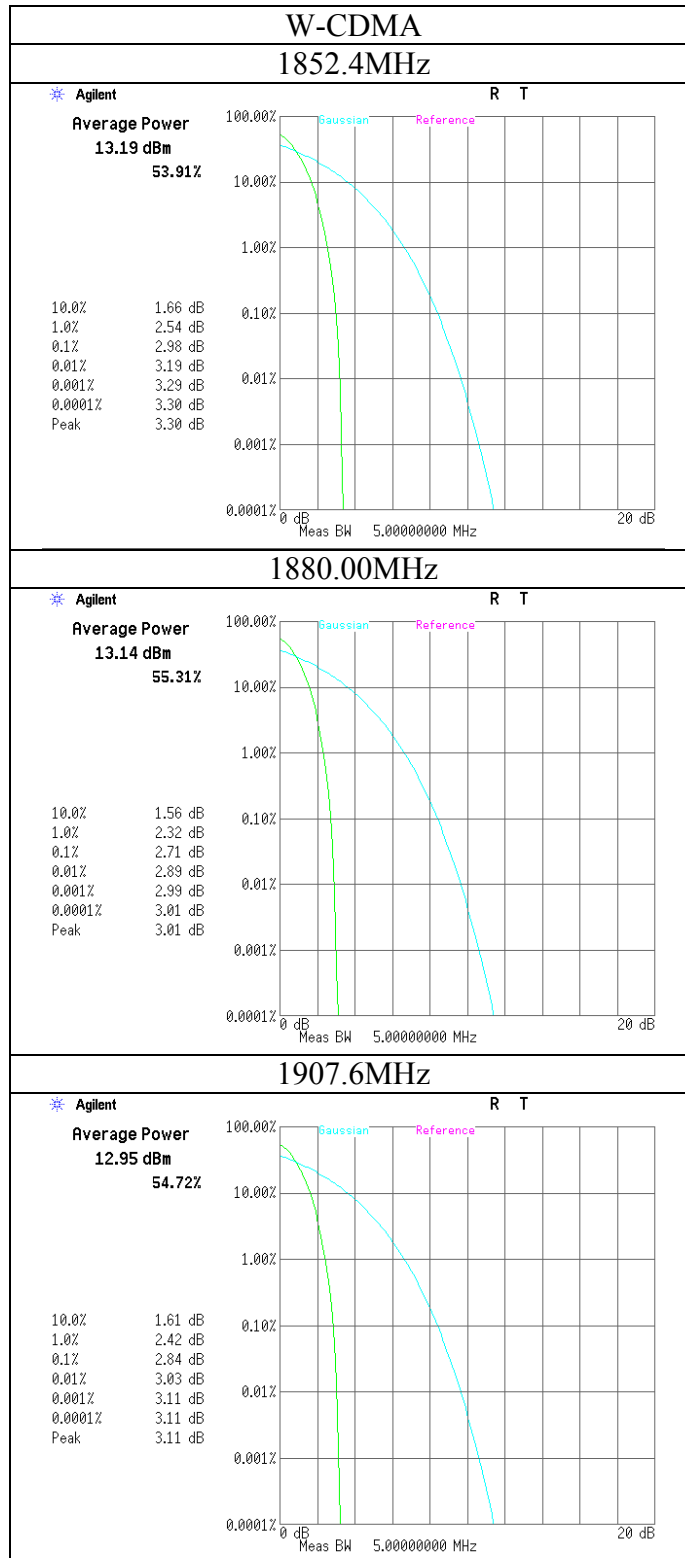
Mode	Channel	Frequency [MHz]	Peak to Average Power Ratio [dB]	Limit [dB]
GSM *1)	512	1850.20	0.055	13
	661	1880.00	0.043	13
	810	1909.80	0.051	13
GPRS *1)	512	1850.20	0.044	13
	661	1880.00	0.042	13
	810	1909.80	0.054	13
EGPRS *1)	512	1850.20	3.167	13
	661	1880.00	3.325	13
	810	1909.80	2.745	13
W-CDMA *2)	9262	1852.40	2.98	13
	9400	1880.00	2.71	13
	9538	1907.60	2.84	13

*In order to decide the largest deviation between the average and the peak power of the EUT in a bandwidth,

*1) an average and a peak trace of the spectrum analyzer was used for GSM Signals ;

*2) Complementary Cumulative Distribution Function (CCDF) curves of the spectrum analyzer were used for W-CDMA Signals.

Peak to Average power Ratio (Conducted)
W-CDMA Band II

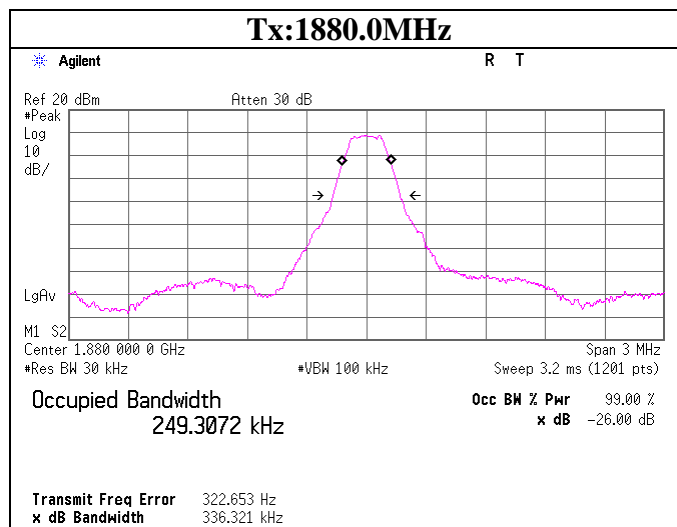


*Set the spectrum analyzer radio mode to 3GPP W-CDMA (Power Stat CCDF)

Bandwidth(Conducted)
PCS1900

Test place	Head Office EMC Lab. No.11 Measurement Room
Report No.	32FE0253-HO-E
Date	02/09/2012
Temperature/ Humidity	20deg. C / 24% RH
Engineer	Yutaka Yoshida
Mode	Tx GSM(GMSK), 1slot, PCL=0

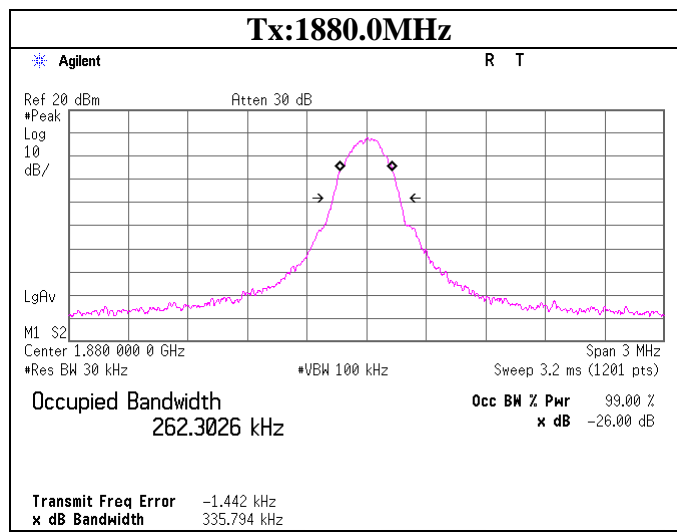
CH	FREQ	26dB Bandwidth	99% OBW	Limit
	[MHz]	[kHz]	[kHz]	[kHz]
Mid	1880.0	336.321	249.3072	-



Bandwidth(Conducted)
PCS1900

Test place	Head Office EMC Lab. No.11 Measurement Room
Report No.	32FE0253-HO-E
Date	02/09/2012
Temperature/ Humidity	20deg. C / 24% RH
Engineer	Yutaka Yoshida
Mode	Tx EGPRS(8PSK), 2slot, MCS-5, PCL=0

CH	FREQ	26dB Bandwidth	99% OBW	Limit
	[MHz]	[kHz]	[kHz]	[kHz]
Mid	1880.0	335.794	262.3026	-

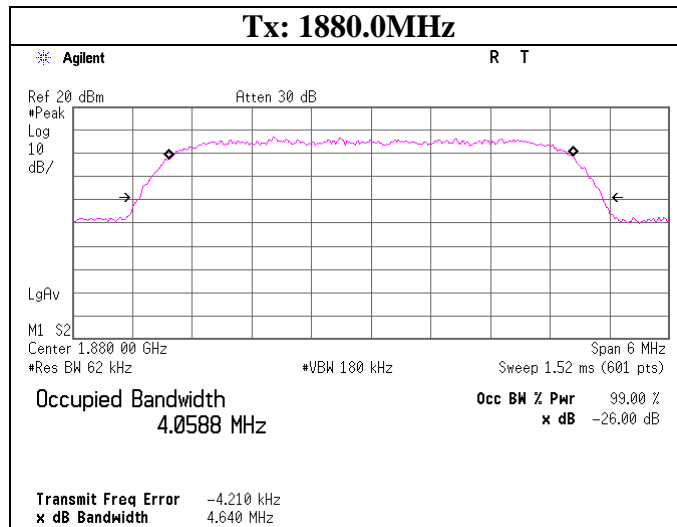


Bandwidth(Conducted)

W-CDMA Band II

Test place	Head Office EMC Lab. No.11 Measurement Room
Report No.	32FE0253-HO-E
Date	02/10/2012
Temperature/ Humidity	23deg. C / 23% RH
Engineer	Yutaka Yoshida
Mode	Tx W-CDMA(RMC12.2kbps), All Up Bits

CH	FREQ	26dB Bandwidth	99% OBW	Limit
	[MHz]	[MHz]	[MHz]	[kHz]
Mid	1880.0	4.640	4.0588	-



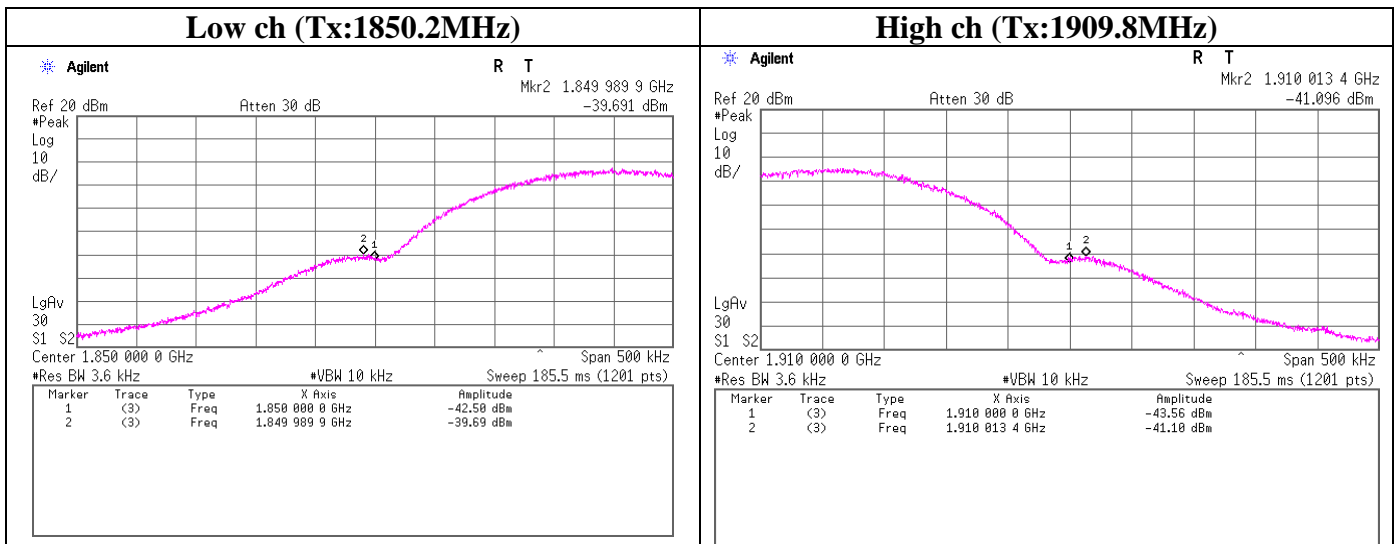
Band-Edge(Conducted)
PCS1900

Test place Head Office EMC Lab. No.11 Measurement Room
Report No. 32FE0253-HO-E
Date 02/09/2012
Temperature/ Humidity 20deg. C/ 24% RH
Engineer Yutaka Yoshida
Mode Tx GSM(GMSK), 1slot, PCL=0

Frequency [MHz]	Reading [dBm]	Atten. [dB]	Cable Loss [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
1849.9899	-39.69	16.16	3.30	-20.23	-13.0	7.23
1850.0000	-42.50	16.16	3.30	-23.04	-13.0	10.04
1910.0000	-43.56	16.16	3.31	-24.09	-13.0	11.09
1910.0134	-41.10	16.16	3.31	-21.63	-13.0	8.63

VIDEO AV 30 times

Sample Calculation : Result = Reading + Atten. + Cable Loss



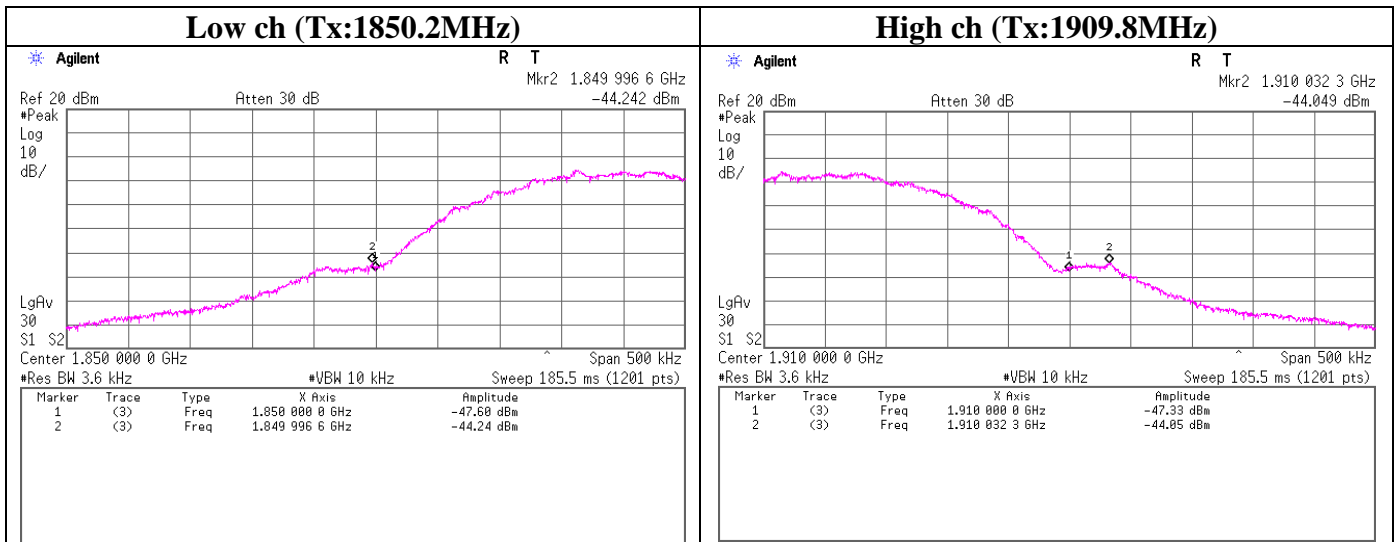
Band-Edge(Conducted)
PCS1900

Test place Head Office EMC Lab. No.11 Measurement Room
Report No. 32FE0253-HO-E
Date 02/09/2012
Temperature/ Humidity 20deg. C/ 24% RH
Engineer Yutaka Yoshida
Mode Tx EGPRS(8PSK), 2slot, MCS-5, PCL=0

Frequency [MHz]	Reading [dBm]	Atten. [dB]	Cable Loss [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
1849.9966	-44.24	16.16	3.30	-24.78	-13.0	11.78
1850.0000	-47.60	16.16	3.30	-28.14	-13.0	15.14
1910.0000	-47.33	16.16	3.31	-27.86	-13.0	14.86
1910.0323	-44.05	16.16	3.31	-24.58	-13.0	11.58

VIDEO AV 30 times

Sample Calculation : Result = Reading + Atten. + Cable Loss



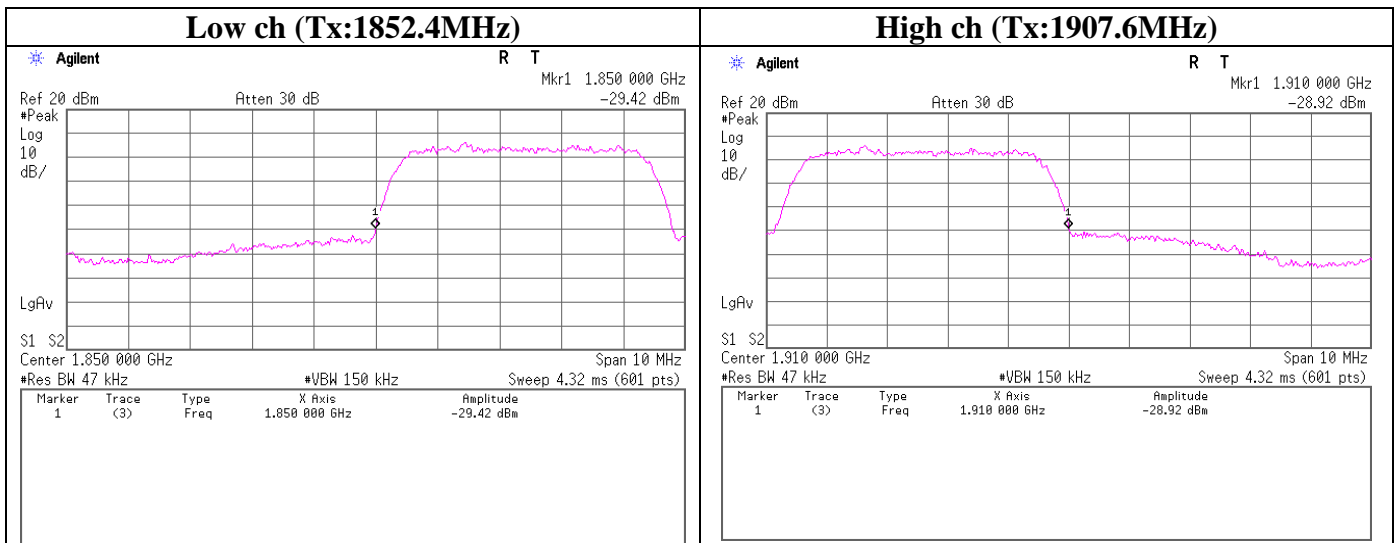
Band-Edge(Conducted)

W-CDMA Band II

Test place	Head Office EMC Lab. No.11 Measurement Room
Report No.	32FE0253-HO-E
Date	02/10/2012
Temperature/ Humidity	23deg.C / 23% RH
Engineer	Yutaka Yoshida
Mode	Tx W-CDMA(RMC12.2kps), All Up Bits

Frequency [MHz]	Reading [dBm]	Atten. [dB]	Cable Loss [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
1850.0000	-29.42	6.09	3.30	-20.03	-13.0	7.03
1910.0000	-28.92	6.09	3.31	-19.52	-13.0	6.52

Sample Calculation : Result = Reading + Atten. + Cable Loss



Band-Edge (Radiated)
PCS1900

Report No. 32FE0253-HO-O
Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date 02/06/2012
Temperature / Humidity 25deg. C / 31% RH
Engineer Satofumi Matsuyama
Mode Tx GSM(GMSK), 1slot, PCL=0

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks		
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]		Rx Ant. Height [cm]	Turn Table [deg.]
1850.00	46.3	44.4	-29.5	-33.5	4.0	9.8	0.0	-23.7	-27.7	-13.0	10.7	14.7	128	0	103	260			
1910.00	42.9	43.9	-32.5	-32.9	4.0	9.8	0.0	-26.7	-27.1	-13.0	13.7	14.1	120	350	100	270			
1910.02	48.7	49.7	-26.6	-27.0	4.0	9.8	0.0	-20.8	-21.2	-13.0	7.8	8.2	120	350	100	270			

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : Tx : S/A PK(RBW:3.6kHz/VBW:10kHz)

Band Edge (Radiated)
W-CDMA Band II

Report No. 32FE0253-HO-O
Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date 02/06/2012
Temperature / Humidity 25deg. C / 31% RH
Engineer Satofumi Matsuyama
Mode Tx W-CDMA (RMC12.2kbps), All Up Bits

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]	Rx Ant. Height [cm]	Turn Table [deg.]	
1910.00	48.8	48.2	-26.9	-29.0	4.01	9.80	0.00	-21.1	-23.2	-13.0	8.1	10.2	124	320	100	262	

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-20GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-20GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A AV (RBW: 47kHz , VBW: 150kHz)

Spurious Emission (Conducted)

PCS1900

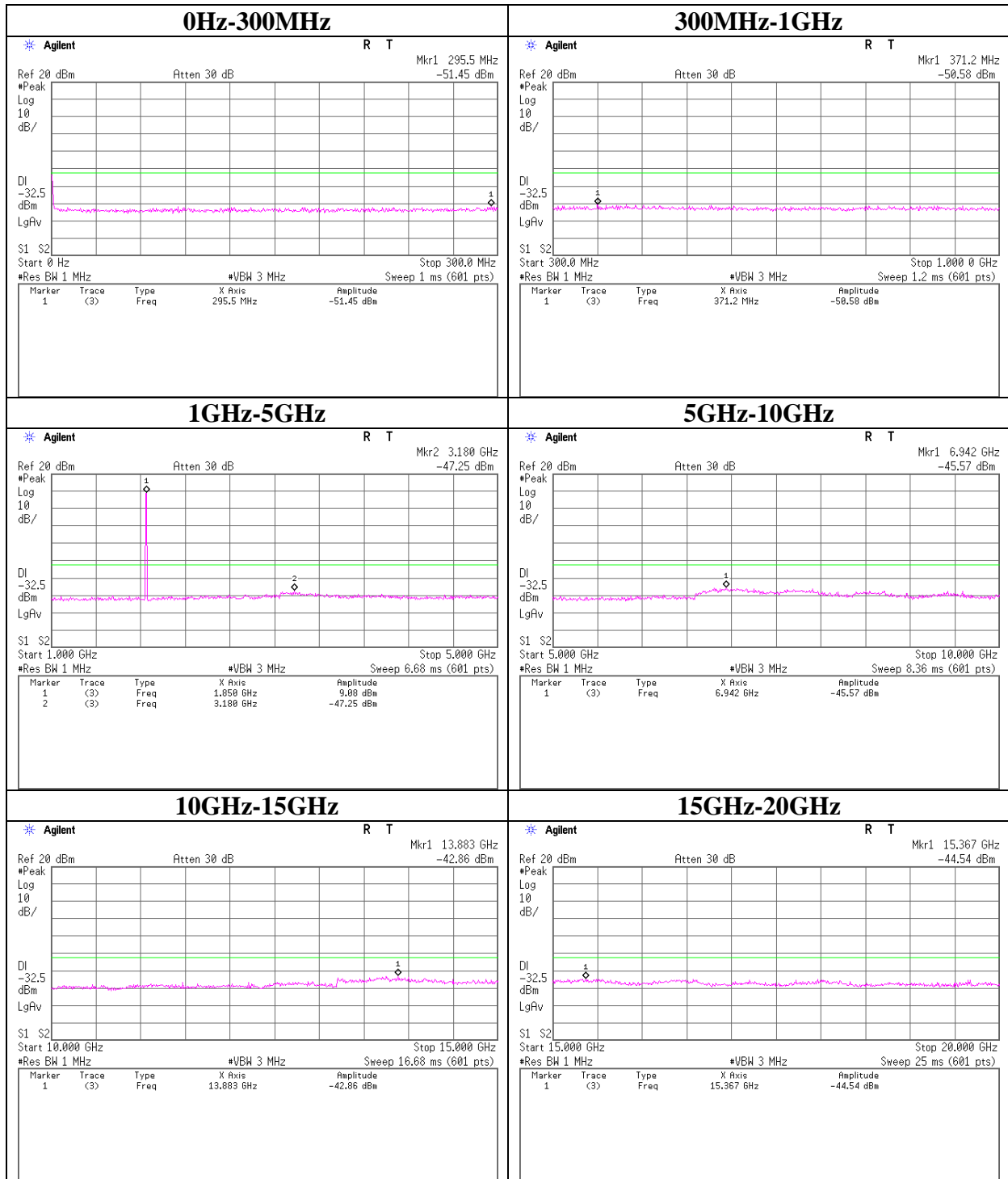
Test place Head Office EMC Lab. No.11 Shielded Room
Report No. 32FE0253-HO-E
Date 02/10/2012
Temperature/ Humidity 23deg. C / 23% RH
Engineer Yutaka Yoshida
Mode Tx GSM(GMSK), 1slot, PCL=0

Limit Line

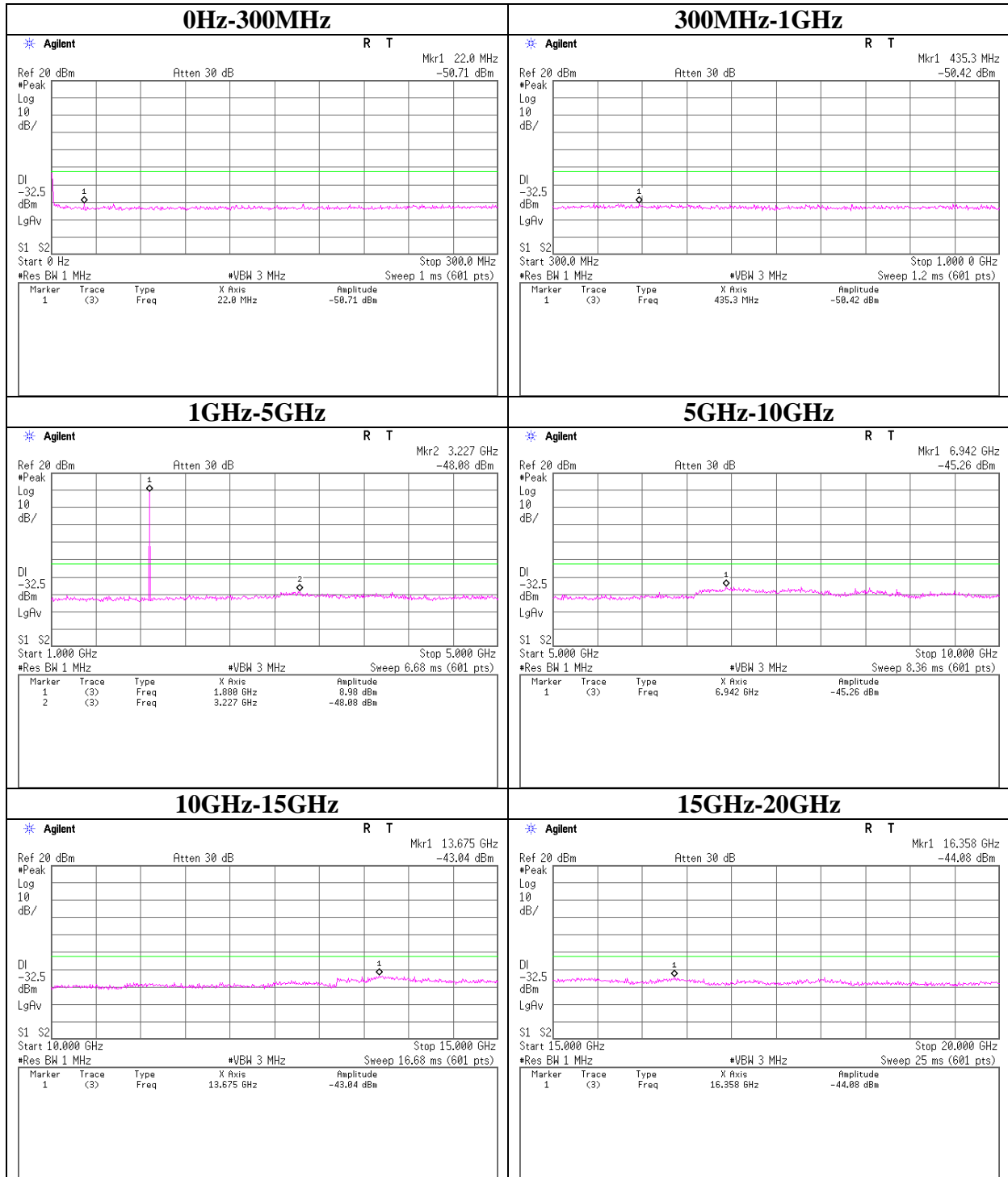
Tx Frequency [MHz]	Limit [dBm]	Atten. [dB]	Cable Loss [dB]	Limit Line [dBm]
1850.2	-13.0	16.16	3.30	-32.5
1880.0	-13.0	16.16	3.30	-32.5
1909.8	-13.0	16.16	3.31	-32.5

Sample Calculation : Limit Line = Limit - Atten. - Cable Loss

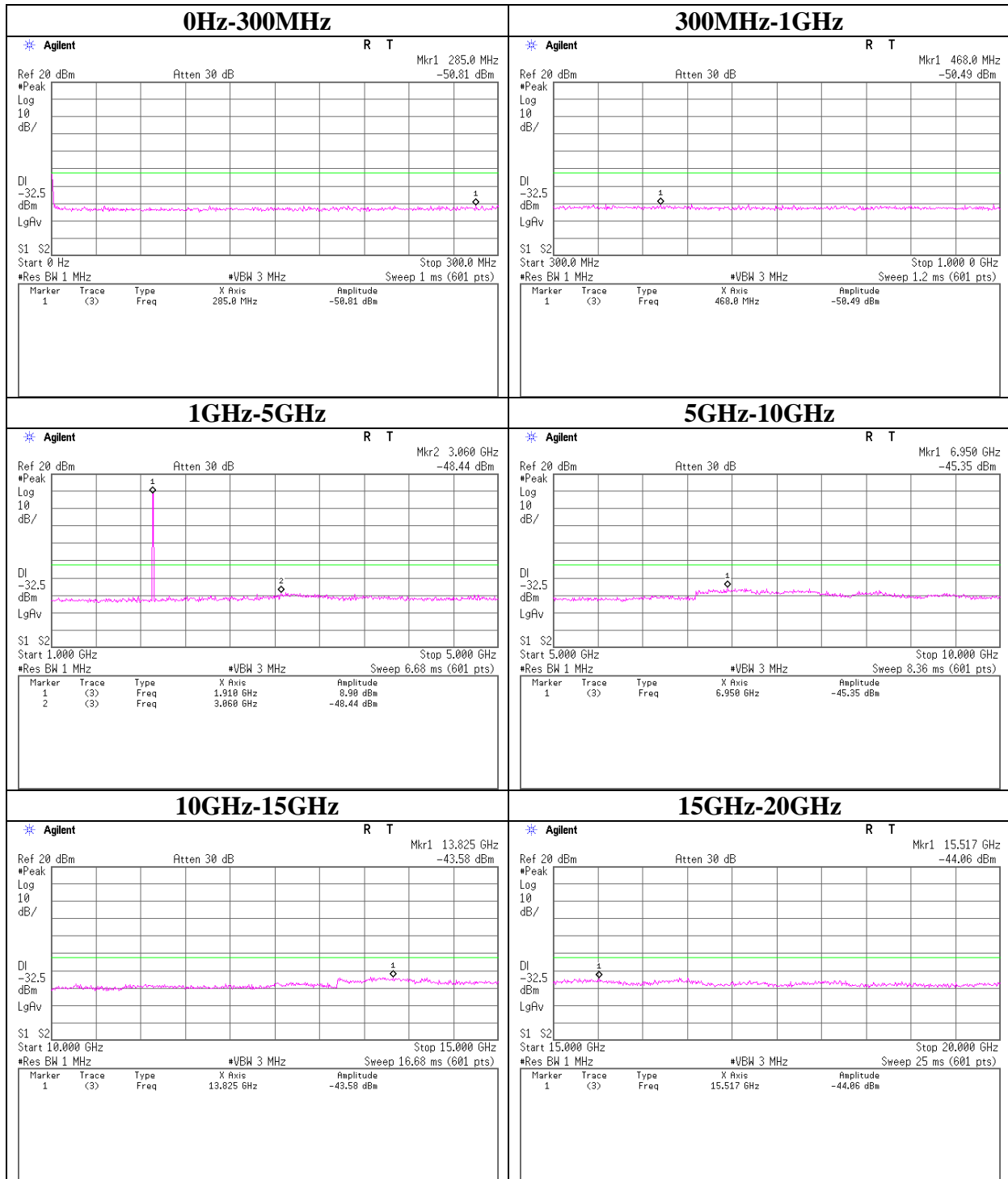
Spurious Emission (Conducted)
GSM
Tx:1850.2MHz



Spurious Emission (Conducted)
GSM
Tx:1880.0MHz



Spurious Emission (Conducted)
GSM
Tx:1909.8MHz



Spurious Emission (Conducted)

PCS1900

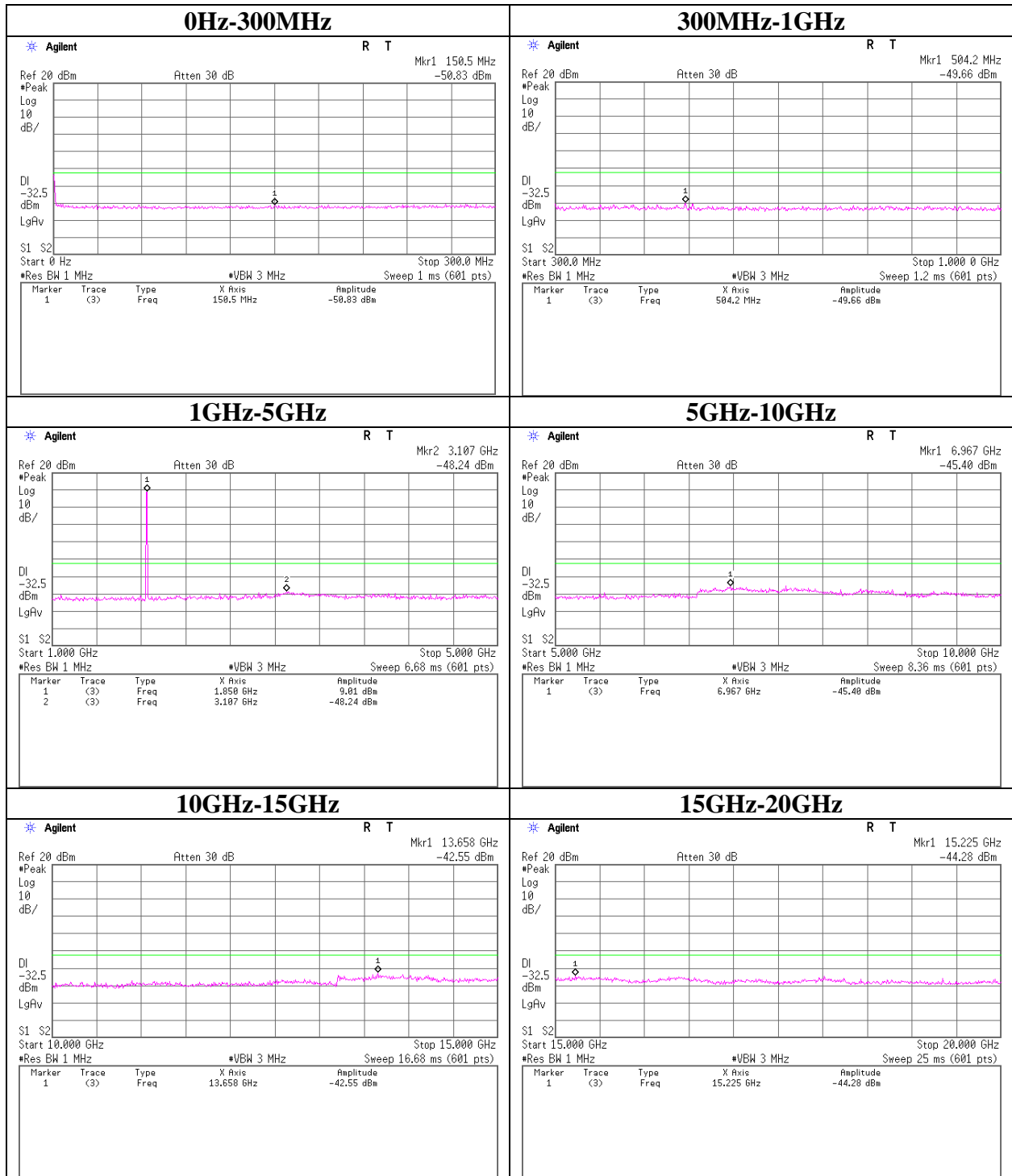
Test place Head Office EMC Lab. No.11 Measurement Room
Report No. 32FE0253-HO-E
Date 02/10/2012
Temperature/ Humidity 23deg. C / 23% RH
Engineer Yutaka Yoshida
Mode Tx EGPRS(8PSK), 2slot, MCS-5, PCL=0

Limit Line

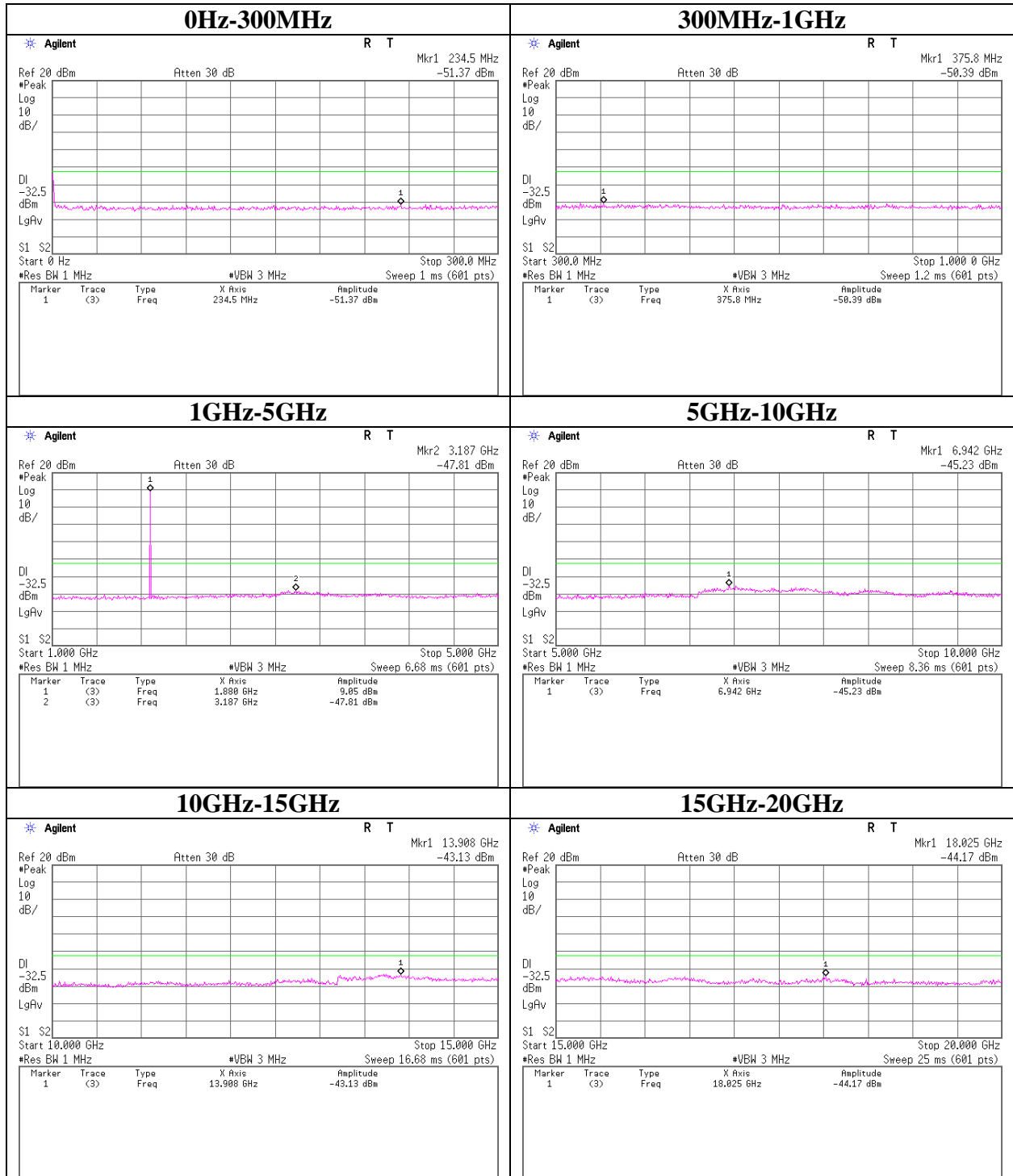
Tx Frequency [MHz]	Limit [dBm]	Atten. [dB]	Cable Loss [dB]	Limit Line [dBm]
1850.2	-13.0	16.16	3.30	-32.5
1880.0	-13.0	16.16	3.30	-32.5
1909.8	-13.0	16.16	3.31	-32.5

Sample Calculation : Limit Line = Limit - Atten. - Cable Loss

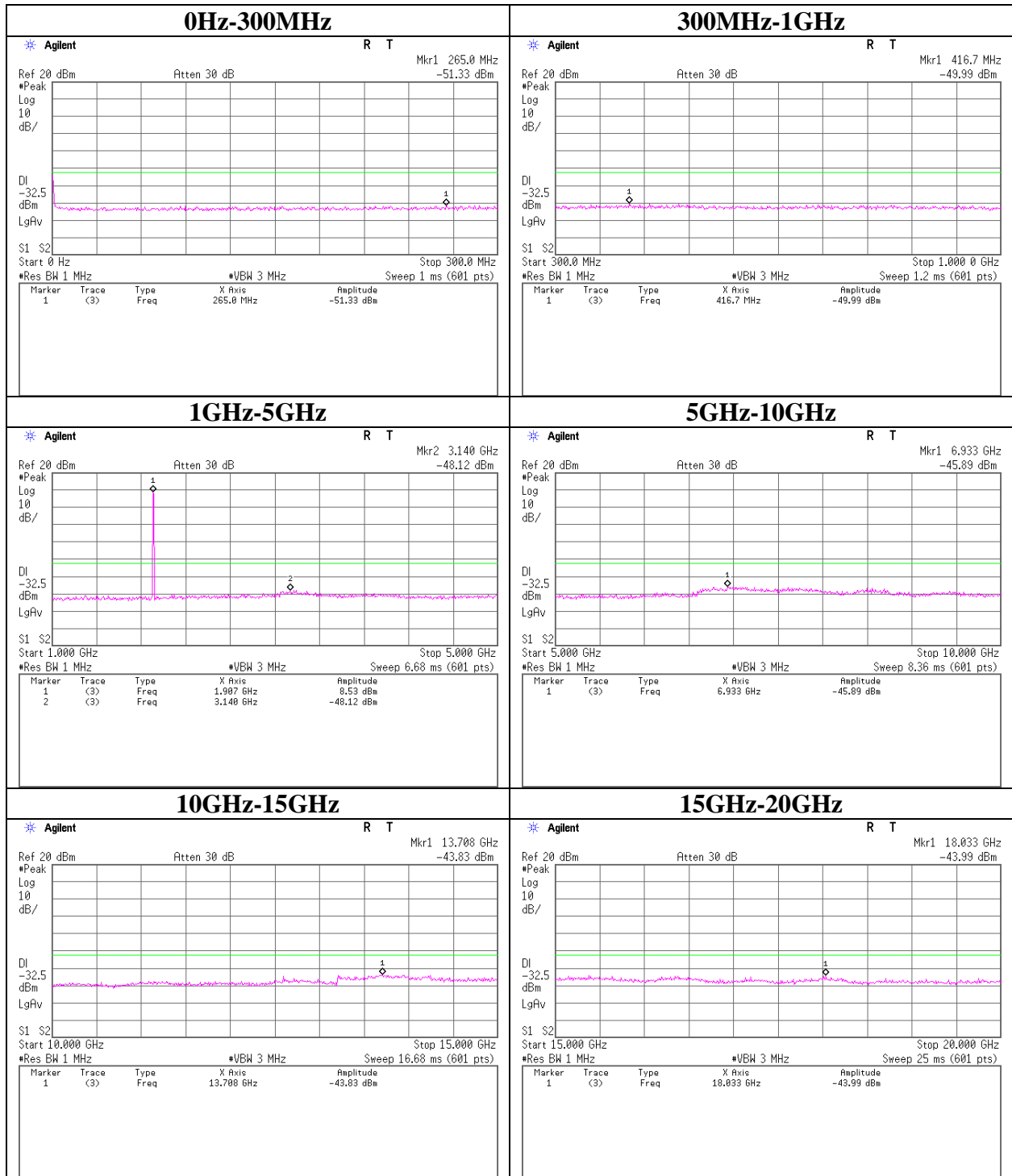
Spurious Emission (Conducted)
EGPRS
Tx:1850.2MHz



Spurious Emission (Conducted)
EGPRS
Tx:1880.0MHz



Spurious Emission (Conducted)
EGPRS
Tx:1909.8MHz



Spurious Emission (Conducted)
W-CDMA Band II

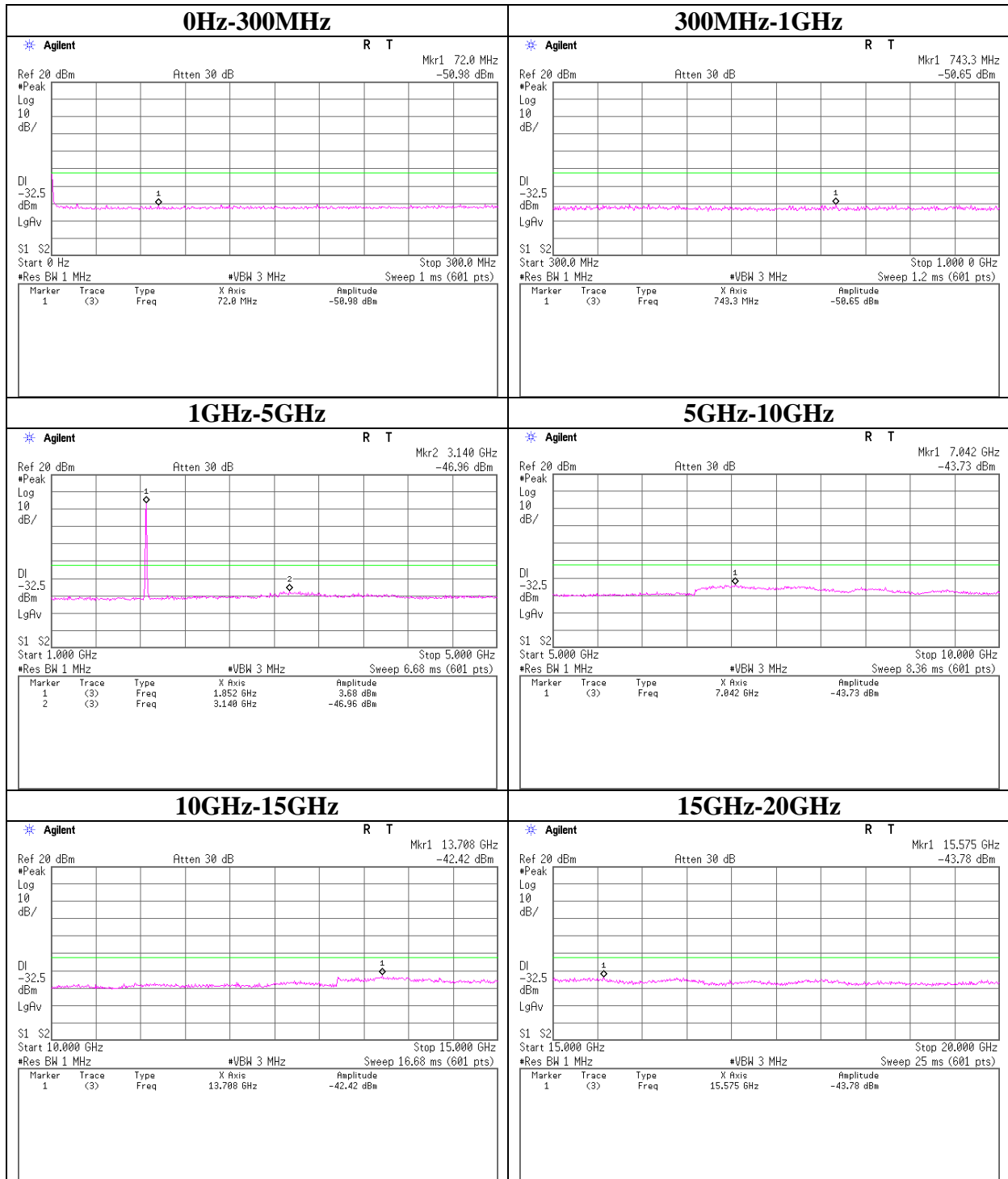
Test place Head Office EMC Lab. No.11 Measurement Room
Report No. 32FE0253-HO-E
Date 02/10/2012
Temperature/ Humidity 23deg. C / 23% RH
Engineer Yutaka Yoshida
Mode Tx W-CDMA(RMC12.2kbps), All Up Bits

Limit Line

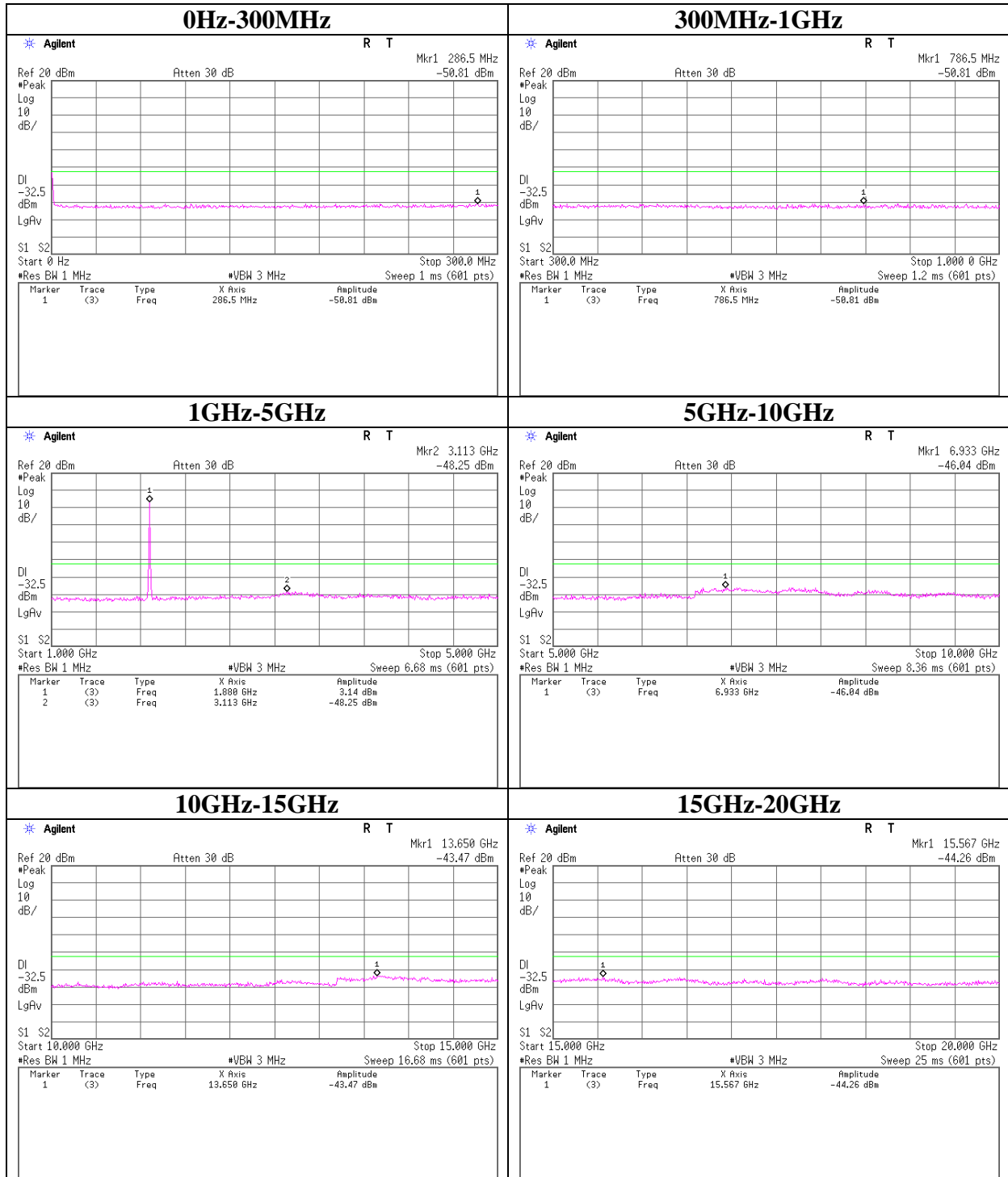
Tx Frequency [MHz]	Limit [dBm]	Atten. [dB]	Cable Loss [dB]	Limit Line [dBm]
1852.4	-13.0	16.16	3.30	-32.5
1880.0	-13.0	16.16	3.30	-32.5
1907.6	-13.0	16.16	3.31	-32.5

Sample Calculation : Limit Line = Limit - Atten. - Cable Loss

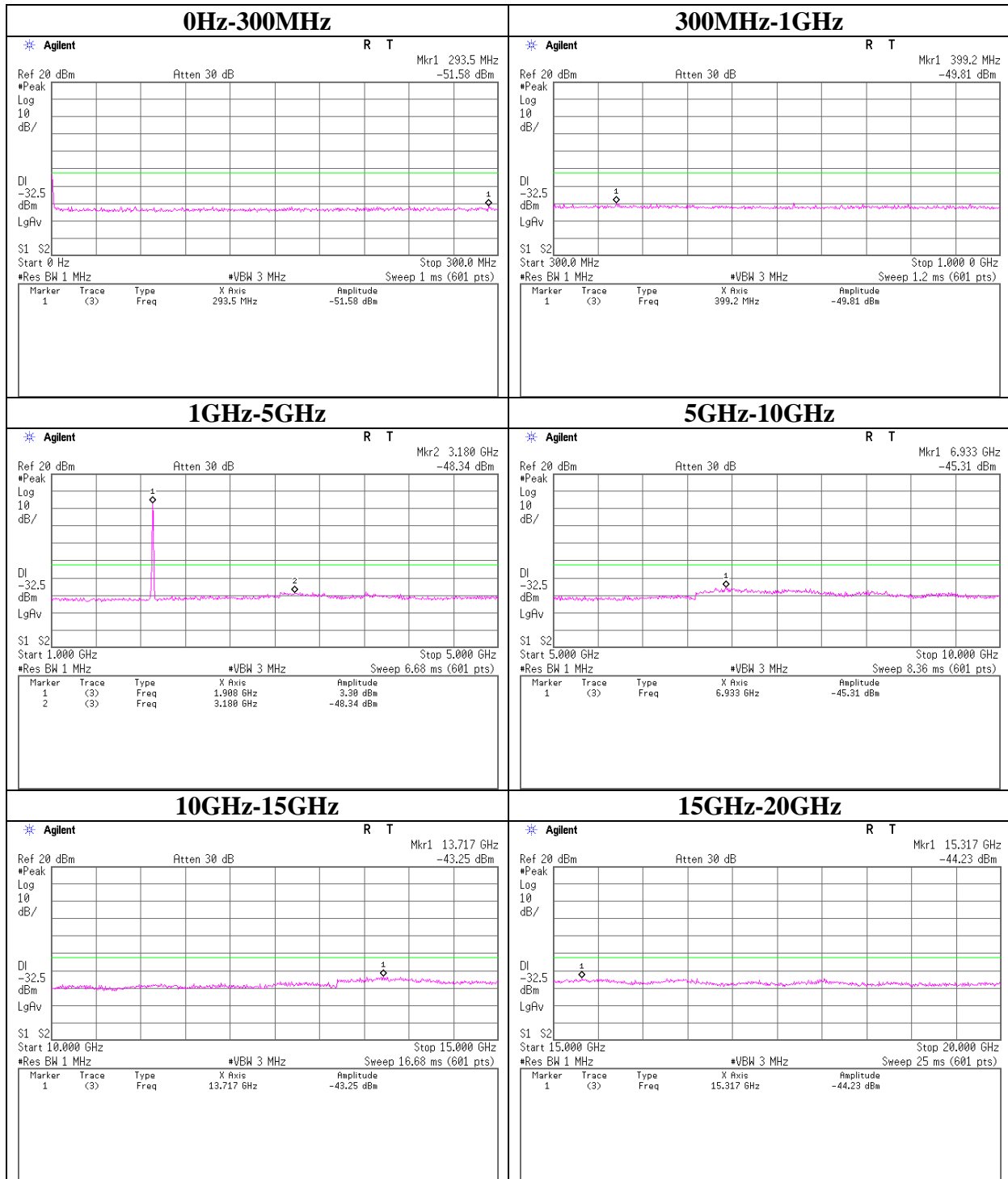
Spurious Emission (Conducted)
W-CDMA Band II
Tx:1852.4MHz



Spurious Emission (Conducted)
W-CDMA Band II
Tx:1880.0MHz



Spurious Emission (Conducted)
W-CDMA Band II
Tx:1907.6MHz



Spurious Emission (Radiated)
PCS1900

Report No. 32FE0253-HO-O
Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date 02/06/2012
Temperature / Humidity 25deg. C / 31% RH
Engineer Satofumi Matsuyama

Mode Tx GSM(GMSK), 1slot, PCL=0

Tx 1850.2MHz

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks				
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	HOR	VER		Rx Ant.	Turn	Rx Ant.	Turn
																		Height	Table	Height	Table
3700.40	46.8	49.3	-63.3	-60.5	4.7	11.9	0.0	-56.1	-53.3	-13.0	43.1	40.3	100	295	127	150					
5550.60	47.8	48.1	-57.2	-59.1	5.7	12.2	0.0	-50.8	-52.7	-13.0	37.8	39.7	100	146	113	138					

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK(RBW:1MHz/VBW:3MHz)

Tx 1880MHz

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks				
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	HOR	VER		Rx Ant.	Turn	Rx Ant.	Turn
																		Height	Table	Height	Table
3760.00	50.2	49.3	-59.9	-60.5	4.7	11.8	0.0	-52.8	-53.4	-13.0	39.8	40.4	100	138	125	158					
5640.00	47.9	47.2	-57.1	-60.0	5.8	12.2	0.0	-50.7	-53.6	-13.0	37.7	40.6	116	141	111	149					

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK(RBW:1MHz/VBW:3MHz)

Tx 1909.8MHz

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks				
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	HOR	VER		Rx Ant.	Turn	Rx Ant.	Turn
																		Height	Table	Height	Table
3819.60	51.8	49.5	-58.3	-60.3	4.8	11.8	0.0	-51.3	-53.3	-13.0	38.3	40.3	100	135	123	159					
5729.40	46.7	45.7	-58.3	-61.5	5.8	12.2	0.0	-51.9	-55.1	-13.0	38.9	42.1	114	154	109	147					

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK(RBW:1MHz/VBW:3MHz)

Spurious Emission (Radiated)
W-CDMA Band II

Report No. 32FE0253-HO-O
Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date 02/06/2012
Temperature / Humidity 25deg. C / 31% RH
Engineer Satofumi Matsuyama

Mode Tx W-CDMA(RMC12.2kbps), All Up Bits

Tx: 1852.4MHz

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks		
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]		Rx Ant. Height [cm]	Turn Table [deg.]
3704.80	NS	NS	-	-	-	-	-	-	-	-13.0	-	-	-	-	-	-	-		

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK(RBW:1MHz/VBW:3MHz)
NS: No signal detected

Tx: 1880.0MHz

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks		
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]		Rx Ant. Height [cm]	Turn Table [deg.]
3760.00	NS	NS	-	-	-	-	-	-	-	-13.0	-	-	-	-	-	-	-		

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK(RBW:1MHz/VBW:3MHz)
NS: No signal detected

Tx: 1907.6MHz

Frequency [MHz]	Rx SA/TR Reading [dBuV]		Tx SG Reading [dBm]		Tx Cable Loss [dB]	Tx Ant. Gain [dBi]	Tx Ant. Atten. Loss [dB]	Result (EIRP) [dBm]		Limit (EIRP) [dBm]	Margin [dB]		Horizontal		Vertical		Remarks		
	HOR	VER	HOR	VER				HOR	VER		HOR	VER	HOR	VER	Rx Ant. Height [cm]	Turn Table [deg.]		Rx Ant. Height [cm]	Turn Table [deg.]
3815.20	NS	NS	-	-	-	-	-	-	-	-13.0	-	-	-	-	-	-	-		

Calculation Result = SG Reading - Tx Cable Loss + Tx Antenna Gain - Tx Antenna Attenuator Loss
Rx-ANTENNA : Biconical Antenna(30M-300MHz), Logperiodic Antenna(300M-1000MHz), Horn Antenna(1G-40GHz)
Tx-ANTENNA : 120MHz tuned Dipole Antenna(30M-120MHz), Dipole Antenna(120M-1000MHz), Horn Antenna(1G-40GHz)
Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).
Detector : S/A PK(RBW:1MHz/VBW:3MHz)
NS: No signal detected

Frequency Stability (Temperature/Voltage Variation)

PCS1900

Tx:1880.0MHz

Test place Head Office EMC Lab. No.6 Measurement Room
Report No. 32FE0253-HO-E
Date 02/12/2012 02/13/2012
Temperature/ Humidity 21 deg. C / 32% RH 22 deg. C / 30% RH
Engineer Hironobu Ohnishi Katsunori Okai
Mode Tx GSM(GMSK), 1slot, PCL=0

Temp. [deg.C]	Volt. [%]	Frequency Reading [MHz]	Frequency Error [Hz]	Frequency Error [ppm]	Limit [ppm]
-30.0	100%	1880.000244	2.70	0.001	2.5
-20.0	100%	1880.000205	1.20	0.001	2.5
-10.0	100%	1880.000237	2.00	0.001	2.5
0.0	100%	1880.000260	4.30	0.002	2.5
10.0	100%	1880.000242	2.50	0.001	2.5
20.0	100%	1880.000217	0.00	0.000	Reference
30.0	100%	1880.000272	5.50	0.003	2.5
40.0	100%	1880.000208	0.90	0.000	2.5
50.0	100%	1880.000226	0.90	0.000	2.5

Temp. [deg.C]	Volt. [%]	Frequency Reading [MHz]	Frequency Error [Hz]	Frequency Error [ppm]	Limit [ppm]
20.0	115%	1880.000229	1.20	0.001	2.5
20.0	100%	1880.000217	0.00	0.000	Reference
20.0	85%	1880.000237	2.00	0.001	2.5

Frequency Stability (Temperature/Voltage Variation)
W-CDMA Band II
Tx: 1880.0MHz

Test place Head Office EMC Lab. No.6 Measurement Room
Report No. 32FE0253-HO-E
Date 02/12/2012 02/13/2012
Temperature/ Humidity 21 deg. C / 32% RH 22 deg. C / 30% RH
Engineer Hironobu Ohnishi Katsunori Okai
Mode Tx W-CDMA(RMC12.2kbps), All Up Bits

Temp. [deg.C]	Volt. [%]	Frequency Reading [MHz]	Frequency Error [Hz]	Frequency Error [ppm]	Limit [ppm]
-30.0	100%	1879.9999795	5.30	0.003	2.5
-20.0	100%	1879.9999874	2.60	0.001	2.5
-10.0	100%	1879.9999846	0.20	0.000	2.5
0.0	100%	1879.9999847	0.10	0.000	2.5
10.0	100%	1879.9999842	0.60	0.000	2.5
20.0	100%	1879.9999848	0.00	0.000	Reference
30.0	100%	1879.9999826	2.20	0.001	2.5
40.0	100%	1879.9999851	-0.30	0.000	2.5
50.0	100%	1879.9999885	-3.70	0.002	2.5

Temp. [deg.C]	Volt. [%]	Frequency Reading [MHz]	Frequency Error [Hz]	Frequency Error [ppm]	Limit [ppm]
20.0	115%	1879.9999874	-2.60	0.001	2.5
20.0	100%	1879.9999848	0.00	0.000	Reference
20.0	85%	1879.9999864	-1.60	0.001	2.5

APPENDIX 2: Test instruments

EMI test equipment (1/2)

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-02	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	RE	2011/06/21 * 12
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	RE	2012/02/06 * 12
MJM-14	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	RE	2011/04/08 * 12
MBA-02	Biconical Antenna	Schwarzbeck	BBA9106	VHA91032008	RE	2011/10/23 * 12
MLA-02	Logperiodic Antenna	Schwarzbeck	USLP9143	201	RE	2011/10/23 * 12
MCC-12	Coaxial Cable	Fujikura/Agilent	-	-	RE	2011/02/18 * 12
MAT-07	Attenuator(6dB)	Weinschel Corp	2	BK7970	RE	2011/11/02 * 12
MPA-09	Pre Amplifier	Agilent	8447D	2944A10845	RE	2011/09/26 * 12
MSG-09	Signal Generator	Wiltron	68247B	674005	RE	2011/02/05 * 12
MDA-04	Dipole Antenna	Schwarzbeck	UHAP	992	RE	2011/10/15 * 12
MCC-125	Corexial Cable	UL Japan	-	-	RE	2011/07/04 * 12
MURC-03	Radio Communication Analyzer	Anritsu	MT8815B	6200711471	RE/AT	2011/11/26 * 12
MHA-20	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	RE	2011/05/23 * 12
MPA-10	Pre Amplifier	Agilent	8449B	3008A02142	RE	2012/01/25 * 12
MCC-132	Microwave Cable	HUBER+SUHNER	SUCOFLEX104	336161/4(1m) / 340639(5m)	RE	2011/09/06 * 12
MHF-06	High Pass Filter 3.5-24GHz	TOKIMEC	TF323DCA	601	RE	2011/05/16 * 12
KSG-05	Signal Generator	Rohde & Schwarz	SMR40	100137	RE	2011/08/30 * 12
MCC-130	Microwave Cable(1-33GHz)	HUBER+SUHNER	SF103/11PC3.5-31/11PC3.5-31/8.0m	54308/3	RE	2012/01/05 * 12
MHA-21	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	RE	2011/08/11 * 12
MHF-03	High pass Filter 1.4-5.0GHz	Mini-Circuit	VHF-1320	10411	RE	2011/08/25 * 12
MSA-10	Spectrum Analyzer	Agilent	E4448A	MY46180655	AT	2012/02/03 * 12
MCC-137	Microwave cable	HUBER+SUHNER	SUCOFLEX 102	37954/2	AT	2011/10/28 * 12
MAT-20	Attenuator(10dB)(above 1GHz)	HIROSE ELECTRIC CO.,LTD.	AT-110	-	AT	2012/01/12 * 12
MURC-01	Universal Radio communication Tester	Rohde & Schwarz	CMU200	106223	AT	Pre Check
MPD-02	Power Divider DC-12.4GHz	SUHNER	4901.19.A	-	AT	2011/05/23 * 12
MOS-27	Thermo-Hygrometer	CUSTOM	CTH-201	A08Q26	AT	2012/02/08 * 12
MCH-04	Temperature and Humidity Chamber	Tabai Espec	PL-2KP	14015723	AT	2011/08/22 * 12
MOS-19	Thermo-Hygrometer	Custom	CTH-201	0001	AT	2011/12/09 * 12
MPSE-17	Power sensor	Anritsu	MA2411B	0738285	AT	2011/08/09 * 12
MPM-12	Power Meter	Anritsu	ML2495A	0825002	AT	2011/08/09 * 12

EMI test equipment (2/2)

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MURC-02	Wireless Communication Test Set	Agilent	E5515C	GB47050683	AT	2011/11/26 * 12
MCC-137	Microwave cable	HUBER+SUHNER	SUCOFLEX 102	37954/2	AT	2011/10/28 * 12
MAT-23	Attenuator(10dB) 1-18GHz	Orient Microwave	BX10-0476-00	-	AT	2011/03/14 * 12
MAT-25	Attenuator(10dB)(above 1GHz)	Agilent	8493C	71642	AT	2011/06/23 * 12
MPSC-01	Power splitters/Combiners	Mini-Circuit	ZFSC-2-2500	0124	AT	2011/09/27 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated Emission

AT: Antenna terminal conducted test

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124